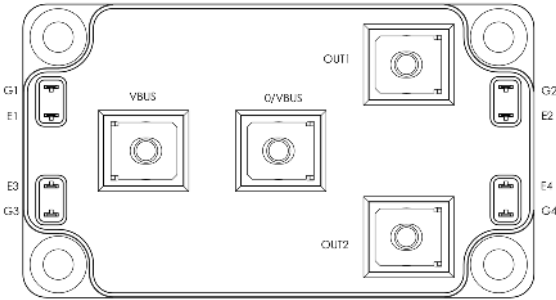
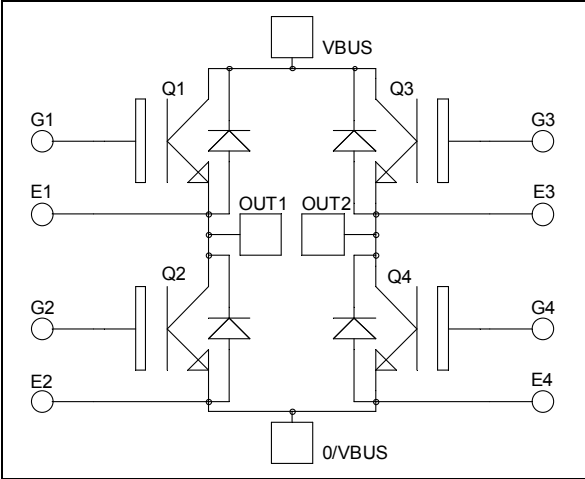


**Full bridge
High speed Trench + Field Stop IGBT4
Power Module**

**$V_{CES} = 650V$
 $I_C = 200A @ T_c = 60^\circ C$**


Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- **High speed Trench + Field Stop IGBT 4 Technology**
 - Low voltage drop
 - Low leakage current
 - Low switching losses
- Very low stray inductance
- Kelvin emitter for easy drive

Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

Absolute maximum ratings (per IGBT)

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>
V_{CES}	Collector - Emitter Voltage	650	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$	270
		$T_C = 60^\circ C$	200
I_{CM}	Pulsed Collector Current	$T_C = 25^\circ C$	540
V_{GE}	Gate - Emitter Voltage	± 20	V
P_D	Power Dissipation	680	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Electrical Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 650V$			75	μA
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_C = 200A$	$T_j = 25^\circ C$ 1.4	1.85	2.3	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 3.2 mA$	4.2	5.1	5.6	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$			300	nA

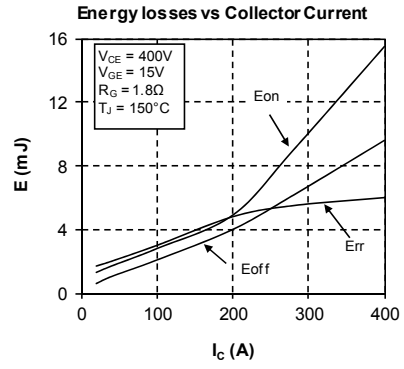
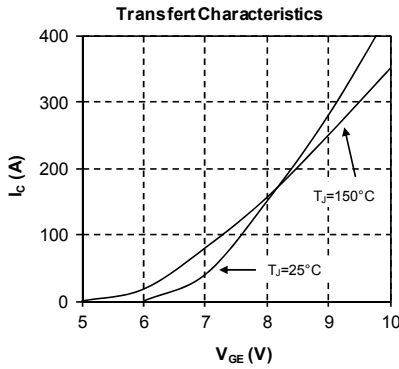
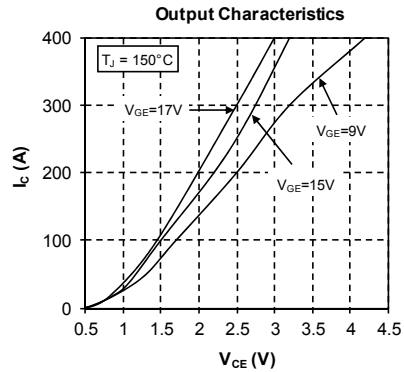
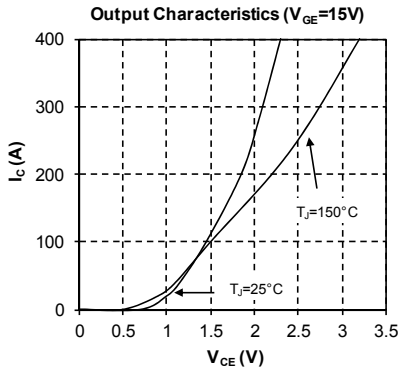
Dynamic Characteristics (per IGBT)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C_{ies}	Input Capacitance	$V_{GE} = 0V$ $V_{CE} = 25V$ $f = 1MHz$		12.2		nF
C_{oes}	Output Capacitance			0.43		
C_{res}	Reverse Transfer Capacitance			0.36		
Q_G	Gate charge	$V_{GE} = 15V, I_C = 200A$ $V_{CE} = 480V$		1260		nC
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C) $V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 200A$ $R_G = 1.8\Omega$		19		ns
T_r	Rise Time			33		
$T_{d(off)}$	Turn-off Delay Time			197		
T_f	Fall Time			21		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (150°C) $V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 200A$ $R_G = 1.8\Omega$		19		ns
T_r	Rise Time			29		
$T_{d(off)}$	Turn-off Delay Time			227		
T_f	Fall Time			22		
E_{on}	Turn on Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 400V$ $I_C = 200A$	$T_j = 150^\circ C$	4.8		mJ
E_{off}	Turn off Energy	$R_G = 1.8\Omega$	$T_j = 150^\circ C$	4		
R_G	Integrated gate resistor			1		Ω
I_{sc}	Short Circuit data	$V_{GE} \leq 15V; V_{Bus} = 400V$ $t_p \leq 5\mu s; T_j = 150^\circ C$		1400		A
R_{thJC}	Junction to Case Thermal Resistance				0.22	$^\circ C/W$

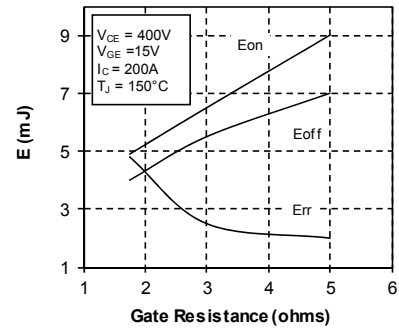
Diode ratings and characteristics (per diode)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V_{RRM}	Peak Repetitive Reverse Voltage				650	V
I_{RM}	Reverse Leakage Current	$V_R = 650V$			50	μA
I_F	DC Forward Current		$T_c = 25^\circ C$	200		A
V_F	Diode Forward Voltage	$I_F = 200A$ $V_{GE} = 0V$	$T_j = 25^\circ C$ 1.6	2		V
t_{rr}	Reverse Recovery Time	$I_F = 200A$ $V_R = 300V$ $di/dt = 2800A/\mu s$	$T_j = 25^\circ C$	125		ns
			$T_j = 150^\circ C$	220		
Q_{rr}	Reverse Recovery Charge		$T_j = 25^\circ C$	9.4		μC
			$T_j = 150^\circ C$	20		
E_{rr}	Reverse Recovery Energy		$T_j = 25^\circ C$	2.2		mJ
		$T_j = 150^\circ C$	4.8			
R_{thJC}	Junction to Case Thermal Resistance				0.39	$^\circ C/W$

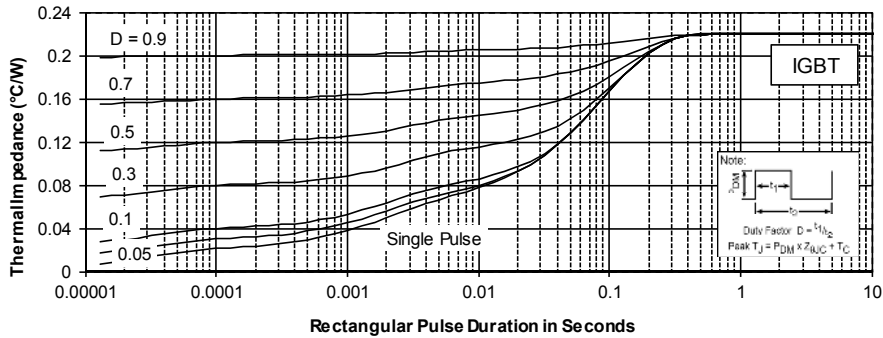
Typical Performance Curve

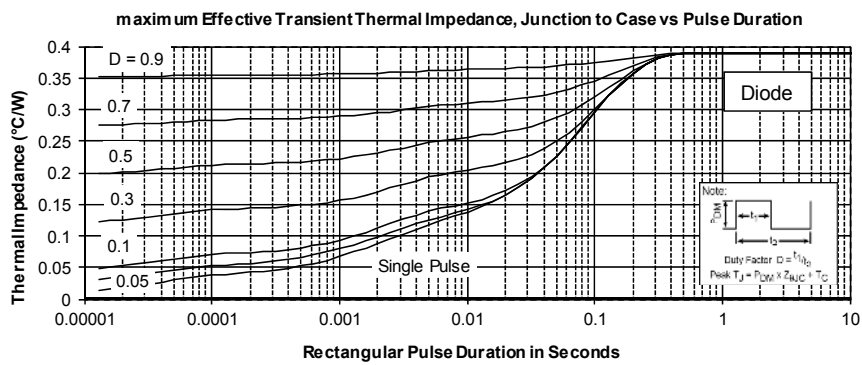
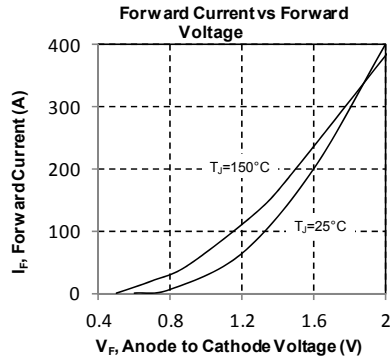
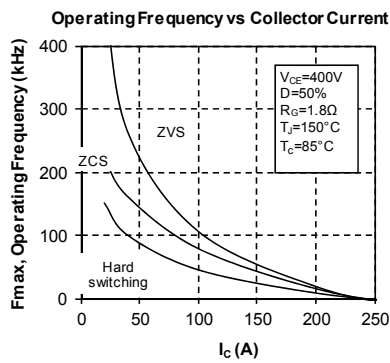


Switching Energy Losses vs Gate Resistance



maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration





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